



**INDIAN INSTITUTE OF TECHNOLOGY BOMBAY, POWAI, MUMBAI
IOE (Institute of Eminence)-Scanning Near Field Optical
Microscopy (SNOM), Central Facility**

Department of Physics

Email: dkabra@iitb.ac.in, 30005980@iitb.ac.in Ph: 022-25766568

**Registration Form for Scanning Nearfield Optical Microscopy
(SNOM) Internal/External Users**

External User Registration No: **Date:**

1) Name of the User:

2) Name of the Institute/Organization:

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(Appropriate letter to be enclosed; please see instruction sheet)

3) GSTIN (if available):

4) Email, Tel No & Mobile No:

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5) Number of samples (max. 3 per slot (3 Hr)):

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6) Slot (10: AM – 1:00 Pm, or 2:30 Pm – 5:30 Pm)

7) Specifications of samples: Material(s) and Substrate (if any)

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8) Nature of sample (Hard/Soft):

9) Mode of Operation (AFM/(SNOM-reflection, collection, transmission, and wavelength required)/CFM(without or with atmosphere)/KPFM(without or with atmosphere)/Fluorescence(wavelength)):

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10) Scan size, & Resolution required:

11) Any other remarks:

MATERIAL IS NOT POISONOUS/TOXIC IN ANY WAY (Please provide MSDS data sheet)

We agree to acknowledge the SNOM (Physics)-IOE, CENTRAL FACILITY of IIT BOMBAY in our Publications/Reports/Thesis in which the data is used with due feedback through email

Signature of the User:

Note: 1). Samples should be brought by the user at the allotted time and the user should be present while the samples are being examined,

2). Size of the sample should not be more than 20 mm X 20 mm X 4 mm.

For Official Use only:

Date of experiment:	Name of the operator:
Results sent to date:	Signature of operator: